



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

COPY OF PAPERS  
ORIGINALLY FILED

In re patent application of

Hamid K. Aghajan

Serial No.: 09/365,517

Filed: August 2, 1999

For: Two-Dimensional Scatter Plot  
Technique for Defect Detection

Group Art Unit: 2621

Examiner: S. C. Chawan

Date: August 8, 2002

RECEIVED

AUG 20 2002

Technology Center 2600

CERTIFICATE OF MAILING under 37 C.F.R. 1.8(a)

I hereby certify that this correspondence is being deposited on August 8, 2002 with the United States Postal Service as first class mail, with sufficient postage, in an envelope addressed to Commissioner for Patents, Washington, D.C. 20231.

Michael B. Einschlag  
Michael B. Einschlag

August 8, 2002  
Date of Signature

Commissioner for Patents  
Washington, D.C. 20231

Sir:

This is in response to the outstanding Office Action mailed March 27, 2002. An Extension Petition is attached hereto to extend the time for responding by two (2) months from June 27, 2002 to and including August 27, 2002.